# Agilent Technologies Z5623A Option K64

# **User's and Service Guide Supplement**

Use this manual with the following documents:

PNA Series Network Analyzer On-line Help System

Application Note 1408-12



Manufacturing Part Number: Z5623-90074 Printed in USA June 2005

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# Warranty Statement

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| WARNING | Warning denotes a hazard. It calls attention to a procedure<br>which, if not correctly performed or adhered to, could result in<br>injury or loss of life. Do not proceed beyond a warning note<br>until the indicated conditions are fully understood and met.                    |
|---------|--|
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# **Statement of Compliance**

This product has been designed and tested in accordance with the standards listed on the Manufacturer's Declaration of Conformity, and has been supplied in a safe condition. The documentation contains information and warnings that must be followed by the user to ensure safe operation and to maintain the product in a safe condition.

# Definitions

- Specifications describe the performance of parameters covered by the product warranty (temperature -0 to 55 °C, unless otherwise noted.)
- *Typical* describes additional product performance information that is not covered by the product warranty. It is performance beyond specification that 80% of the units exhibit with a 95% confidence level over the temperature range 20 to 30 °C. Typical performance does not include measurement uncertainty.
- *Nominal* values indicate expected performance, or describe product performance that is useful in the application of the product, but is not covered by the product warranty.

# Contents

| General Information                                    |           |
|--|-----------|
| Description  | . 2       |
| Content List.  | . 3       |
| General Specifications                                 | . 4       |
| Power Requirements                                     | . 4       |
| Environmental Requirements                             | . 5       |
| Equipment Heating and Cooling                          | . 5       |
| Required Conditions for Accuracy Enhanced Measurement  | . 5       |
| Dimensions and Space Requirements                      | . 6       |
| DUT Control Limits                                     | . 6       |
| Maximum Power Levels                                   | . 7       |
| Operation  | . 9       |
| Z5623AK64 High Power Test Set                          | 11        |
| Test Set Status LEDs                                   | 11        |
| Reference Access Ports - SMA (female)                  | 11        |
| Port 5 Access Ports - SMA (female)                     | 11        |
| Test Set Connector Access Ports - SMA (female)         | 11        |
| Test Ports - 3.5 mm Bulkhead Test Ports (male)         | 12        |
| Line Switch  | 12        |
| DUT Control  | 12        |
| Line Module  | 12        |
| Available Fuses  | 13        |
| Test Set Interface                                     | 13        |
| Pass Through Interface                                 | 13        |
| System Setup.  | 14        |
| Attaching the Test Set to the PNA                      | 14        |
| Preparing the Network Analyzer                         | 14        |
| RF Cable Connections                                   | 16        |
| High Power System Setup                                | 18        |
| DUT Control  | 19        |
| Setting the Control Line                               | 19        |
| Pin Assignment   |           |
| Setting the Voltage of the Variable Voltage Output     | 22        |
| Connect to the DUT                                     |           |
| Connecting to the DUT With an External dc Power Supply | 23        |
| Controlling the Test Set                               | 24        |
| Key Conventions  | 24        |
| PNA Interface Control                                  | 24        |
| Overview   |           |
| PNA GPIB Command Processor.                            | 28        |
| Write Commands   | <b>29</b> |
| Read Commands  |           |
| Test Set I/O Interface Commands                        |           |
| Switch Address and Data                                | 30        |
| Control Lines  | 32        |

# Contents

| High Power Measurements With Z5623AK64         | 34 |
|--|----|
| Initial Setup                                  | 34 |
| Determining Power Levels.                      | 36 |
| Selecting Power Ranges and Attenuator Settings | 38 |
| Final Setup                                    | 40 |
| Test Set Internal Configurations               | 42 |
| Bypass   | 42 |
| High Power                                     | 44 |
| Specification                                  | 46 |
| Declaration of Conformity                      | 46 |
| Servicing the Z5623AK64 High Power Test Set.   | 47 |
| Service Information                            | 47 |
| Shipping Instructions.                         | 47 |
| Theory of Operation                            | 48 |
| RF Components                                  | 48 |
| Test Set Interface Control                     | 49 |
| Safety and Regulatory Information              | 55 |
| Introduction                                   | 55 |
| Before Applying Power                          |    |
| Connector Care and Cleaning                    |    |
| Compliance with Canadian EMC Requirements      |    |
| Compliance with German Noise Requirements      |    |
| Warnings                                       | 56 |
| Cautions                                       | 57 |
| Instrument Markings                            |    |
| Contacting Agilent.                            | 59 |

# **General Information**

# Description

The Agilent Z5623AK64 is a 10 MHz to 20 GHz High Power Test Set. When connected to the N5230A 4-Port PNA-L Series Network Analyzer. High power forward direction measurements can be made from Test Port 5 to Port 6.

The Z5623AK64 can be configured in several ways. The Test Set Bypass configuration allows the user to use N5230A 4-Port PNA-L Series Network Analyzer from 10 MHz to 20 GHz in its normal mode. This mode bypasses the Test Set's internal couplers through solid-state switches. The performance of Ports 1 and 4 of the N5230A 4-Port PNA-L Series Network Analyzer are degraded due to cable and switch loss in the Test Set. In the High Power mode the Test Set can be configured for specific application needs by the insertion of high power amplifiers, attenuators, isolators and other signal conditioning accessories. This will allow high power measurements at RF levels up to 20 Watts (+43 dBm) from 10 MHz to 20 GHz.

The N5230A rear panel Test Set I/O 25 pin D-sub connector controls the Z5623AK64 High Power Test Set. The N5230A 4-Port PNA-L Series Network Analyzer has an Interface Control panel that will allow the user to send address and data to the High Power Test Set. Information about the Interface Control can be found in the PNA on line help menu under Interface Control. N5230A PNA-L Series Network Analyzer information, Data sheets, white papers, or manuals can be viewed or printed by visiting our web site at http://www.agilent.com/find/pna.

The High Power configuration requires an amplifier, attenuators, and isolator and that is connected to the Test Set's front panel access source and receiver ports to protect the test set and network analyzer. Agilent does not supply these accessories with the Z5623AK64.

Currently the PNA using the Interface Control only supports a Thru Response Calibration in the High Power mode.

The Test Set is shipped from the factory with jumper cables installed on the front.

# **Content List**

| Agilent<br>Part Number | Description                          |   |
|------------------------|--------------------------------------|---|
| Z5623-90074            | User's and Service Guide Supplement  | 1 |
| 8120-6818              | Test Set I/O Cable                   | 1 |
| E8356-20072            | Front Panel RF Access Jumpers        | 5 |
| Z5623-20418            | Short Interconnect RF Access Jumpers | 5 |
| Z5623-20419            | Long Interconnect RF Access Jumpers  | 5 |
| 5063-9235              | Rack Mount Kit                       | 1 |
| 5063-9228              | Front Handle Kit                     | 1 |
| Z5623-20239            | Rear Attach Bracket (Right)          | 1 |
| Z5623-20240            | Rear Attach Bracket (Left)           | 1 |
| 0515-0686              | Screw, M4 x 0.7 (20 mm)              |   |
| 0515-1499              | Screw, M3.5 x 0.6 (4 mm)             | 8 |
| 1600-1423              | Lock-Link                            | 4 |
| 2680-0179              | Screw (0.5 in)                       | 2 |

# **General Specifications**

## **Power Requirements**

Verify that the required ac power is available at all necessary locations before installing the Test Set to the PNA.

- Three-wire power cables (which provide a safety ground) must be used with all instruments.
- Air-conditioning equipment (or other motor-operated equipment) should not be placed on the same ac line that powers the Test Set and PNA.
- Table 1 contains the maximum VA rating and BTU/hour rating for all instruments. This table can be use to determine the electrical and cooling requirements.

**NOTE** Values are based on 120 Vac supplied to each instrument at 60 Hz.

#### Table 1Power Requirements

| Standard Equipment |                      |                     |
|--------------------|----------------------|---------------------|
| Instrument         | Maximum<br>VA Rating | Maximum<br>BTU/Hour |
| N5230A             | 350                  | 1195                |
| Z5623AK64          | 320                  | 1095                |
| Total              | 670                  | 2290                |

## **Environmental Requirements**

The environmental requirements of the system are listed in Table 2. Note that these requirements are the same as those of the N5230A Network Analyzer with Option 245.

| Temperature                                 |   |
|---|---|
| Operation                                   | 5 °C to 40 °C (41 °F to 104 °F)   |
| Storage                                     | -40 °C to +65 °C (-40 °F to +158 °F)  |
| MeasurementCalibration                      | 20 °C to 26 °C (68 °F to 79 °F)   |
| Performance Verification                    | Temperature must be within 1 °C (1.8 °F) of<br>the temperature at which the measurement<br>calibration was performed. |
| Relative Humidity                           |   |
| Operation                                   | 5% to $95%$ at 40 °C or less (non-condensing)   |
| Storage                                     | $5\%$ to $95\%$ at $65\ ^{\circ}\mathrm{C}$ or less (non-condensing)  |
| Pressure Altitude<br>(Operation or Storage) | Less than 3000 meters (~ 9,800 feet)  |

#### **Equipment Heating and Cooling**

If necessary, install air conditioning and heating to maintain the ambient temperature within the appropriate range. Air conditioning capacity must be consistent with the BTU ratings given in Table 1.

#### **Required Conditions for Accuracy Enhanced Measurement**

Accuracy-enhanced (error-corrected) measurements require the ambient temperature of the PNA and Test Set to be maintained within  $\pm$  1 °C of the ambient temperature at calibration.

## **Dimensions and Space Requirements**

Standard installation of the Z5623AK64 and PNA includes configuration and installation on a customer provided lab bench or table top of adequate size and strength.

Table 3System Dimensions

| Item                          | Weight         |  |
|-------------------------------|----------------|--|
| Required Bench Top Dimension: |                |  |
| Clearance above the bench     | 43 cm (17 in)  |  |
| Width                         | 127 cm (50 in) |  |
| Depth                         | 102 cm (40 in) |  |
| Weight                        | 55 kg (110 lb) |  |

 Table 4
 Instrument Dimensions

| Model     | Weight        | Height    | Width     | Depth     |
|-----------|---------------|-----------|-----------|-----------|
| N5230A    | 29 Kg, 7.5 lb | 26.7 cm   | 42.5 cm   | 42.6 cm   |
|           | (± 0.5 lb)    | (10.5 in) | (16.7 in) | (16.8 in) |
| Z5623AK64 | 9.1 Kg        | 19.1 cm   | 42.5 cm   | 42.6 cm   |
|           | (20lb)        | (7.5 in)  | (16.7 in) | (16.8 in) |

# **DUT Control Limits**

#### Table 5Control Limits

| Item                      | Specifications                  |
|---------------------------|---------------------------------|
| Connector Shape           | 15-pin female D-Sub             |
| Voltage Range:            |                                 |
| Positive Input            | 0 to +5 V                       |
| Negative Input            | -5 to 0 V                       |
| Maximum Current           | 100 mA in total of each<br>line |
| Impedance                 | < 10 Ω                          |
| Range of Variable Voltage | +2 to +5 V                      |

## **Maximum Power Levels**

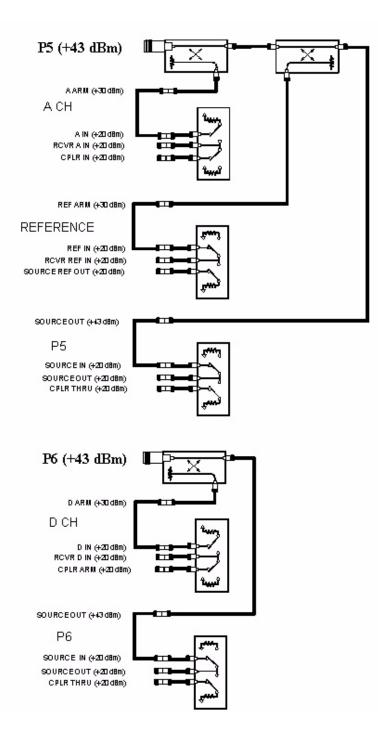
**CAUTION** It is recommend that you do not operate components near damage or maximum levels. The power levels should be kept at less than 3 dB, preferably 6 dB, below damage and maximum levels.

| Test Setup   | Power Level   |  |
|--|---------------|--|
| Maximum Z5623AK64 RF Power Levels for Access and Test Ports: |               |  |
| SOURCE REF OUT, RCVR REF IN                                  | +20 dbm 0 VDC |  |
| REF IN   | +20 dBm 0 VDC |  |
| REF ARM  | +30 dbm 0 VDC |  |
| SOURCE P5 IN   | +20 dBm 0 VDC |  |
| SOURCE P5 OUT  | +43 dbm 0 VDC |  |
| A IN   | +20 dBm 0 VDC |  |
| AARM   | +30 dbm 0 VDC |  |
| CPLR ARM, RCVR A IN  | +20 dBm 0 VDC |  |
| SOURCE OUT, CPLR THRU  | +20 dbm 0 VDC |  |
| SOURCE P6 IN   | +20 dBm 0 VDC |  |
| SOURCE P6 OUT  | +43 dbm 0 VDC |  |
| D IN   | +20 dBm 0 VDC |  |
| D ARM  | +30 dbm 0 VDC |  |
| CPLR ARM, RCVR D IN  | +20 dBm 0 VDC |  |
| SOURCE OUT, CPLR THRU  | +20 dbm 0 VDC |  |
| Test Ports 5 and 6   | +43 dBm 0 VDC |  |
| Maximum PNA-L RF Power Levels to Access and Test Ports:      |               |  |
| Max Recommended RF Level at A/B/C/D/R Receivers              | – 15 dbm      |  |
| Damage Level at A/B/C/D/R Receivers                          | +15 dbm       |  |
| Max Recommended RF Level at Port 1, 2, 3, 4 Source           | +0 dBm        |  |
| Damage Level to Port 1, 2, 3, 4 Source Out                   | +20 dBm       |  |
| Max Level to Port 1, 2, 3, 4 Test Ports                      | +20 dBm       |  |
|  |               |  |

#### Table 6Power Levels

**NOTE** Refer to your PNA-L specifications to optimize the power levels in the receivers.

#### Figure 1 Signal Path Power Levels



# Operation

The Agilent Z5623AK64 High Power Test Set can be configured for many applications. Included in this document are three typical configurations:

- Agilent Z5623AK64 Shipped Configuration, see Figure 2 on page 11.
- Agilent Z5623AK64 Setup Configuration, see Figure 9 on page 17.
- Agilent Z5623AK64 High Power Configuration, see Figure 10 on page 18.

| NOTE    | The internal firmware of the Agilent N5230A 4-Port PNA-L Series Network<br>Analyzer has not been modified for this test set option. Power levels may<br>differ from those indicated on the PNA when the Test Set is connected.  |
|---------|---|
|         |   |
| NOTE    | Refer to the enclosed configuration diagrams for external component<br>connections and/or operating constraints when utilizing the high power<br>capability of the Z5623AK64. External components are not supplied with the<br>Z5623AK64 High Power Test Set.   |
|         |   |
| CAUTION | The Z5623AK64 High Power Test Set is equipped with receiver access ports.<br>The jumpers can be removed to insert attenuators that will reduce the RF<br>power to the PNA-L A,B and R channel receivers. Recommended power levels<br>to the PNA-L receiver ports is -15 dBm. Refer to your PNA-L specifications to<br>optimize power levels to the receiver ports.  |
| μ       |   |
| CAUTION | Prior to powering-up the booster amplifier it is highly recommended that the<br>user verify the RF power levels seen by the various elements of the test setup.<br>Both the PNA and Test Set power levels must be taken into consideration. At<br>high power levels, a mistake could permanently damage the instruments.<br>Accordingly, the following key values are given in Figure 1 on page 8 and<br>Table 6 on page 7. |

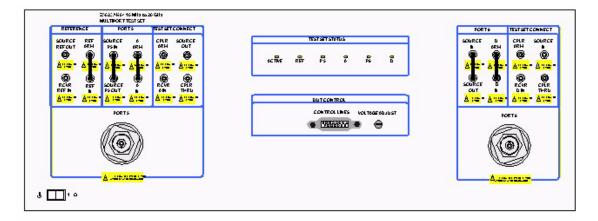
**NOTE** The N5230A 4-Port PNA-L Series Network Analyzer comes with the Interface Control application. Please review this application before connecting the Z5623AK64 Test Set to the PNA. Information regarding this application can be found in the PNA's Help Menu under "InterfaceControl". The application is shown below.



| Interface Control             |                                  |  |  |
|-------------------------------|----------------------------------|--|--|
|                               | le Interface Control             |  |  |
| Before Sweep Start After Swee | ep End                           |  |  |
| GPIB Commands - BEFORE        |                                  |  |  |
|                               | *                                |  |  |
| Handler I/O Control           | Test Set I/O Control (addr.data) |  |  |
| Enable Control                | Enable Control                   |  |  |
| Port A (0-255)                | A                                |  |  |
| Port B (0-255)                | <b>_</b>                         |  |  |
| Port C (0-15)                 |                                  |  |  |
| Port D (0-15)                 | Aux I/O Output Voltage           |  |  |
| Dwell After Command           | DAC1 (-10V -> +10V)              |  |  |
| ms                            | DAC2 (-10V -> +10V)              |  |  |
| Reset All Save Rec            | call OK Cancel Help              |  |  |

## Z5623AK64 High Power Test Set

#### Figure 2 Front Panel (High Power Test Set)



#### **Test Set Status LEDs**

ACTIVE - On = the Test Set is being addressed. Off = Test Set is *not* being addressed.
REF - On = the Test Set reference is in use. Off = the reference is set to the PNA.
P5 - On = the Source is connected to Port 5. Off = the Source is connected to Port 1 of the PNA.
A - On = A Channel is connected to Port 5. Off = A Channel is connected to Port 1 of the PNA.
P6 - On = the Source is connected to Port 6. Off = the Source is connected to Port 4 of the PNA.
D - On = D Channel is connected to Port 6. Off = A Channel is connected to Port 4 of the PNA.

#### **Reference Access Ports - SMA (female)**

SOURCE REF OUT - Receives PNA Reference Source.
RCVR REF IN - Output for PNA Reference Receiver.
REF ARM - Test Set's Reference Output from Reference Coupler.
REF IN - Test Set's Reference Input to Reference Switch.

#### Port 5 Access Ports - SMA (female)

**SOURCE IN** - Source from PNA.

SOURCE OUT - Source to Test Port 5.

A ARM - Tests Set's A Channel Output from A Channel Switch.

A IN - Input to A Channel Switch.

#### Test Set Connector Access Ports - SMA (female)

**CPLR ARM** - A Channel Input from PNA port 1.

 ${\bf RCVR} \ {\bf A} \ {\bf IN}$  - A Channel Output from Test Set A Channel switch.

SOURCE OUT - Test Port 1 Source Input from PNA.

**CPLR THRU** - Source Output to PNA Port 1 from Test Set Port 5 switch.

#### Test Ports - 3.5 mm Bulkhead Test Ports (male)

**PORT 5** - Incident High Power Port

**PORT 6** - Receive High Power Port

Line Switch

Standby - OFF

1 - ON, Power LED On

#### **DUT Control**

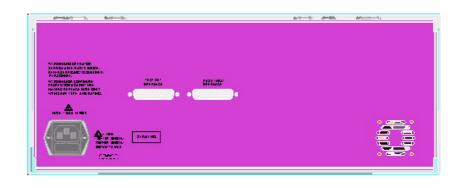
**CONTROL LINES** - 8 Lines that can supply voltage to assist in controlling a DUT.

**VOLTAGE ADJUS**T - Adjustment resistor to vary Pin 12 of the DUT CONTROL from 2 to 5 volts.

#### Line Module

The line fuse, as well as a spare, reside within the line module. Figure 3 illustrates where the fuses are located and how to access them.

#### Figure 3 Rear Panel (High Power Test Set)



#### **Available Fuses**

- United States (115 V orientation) Fuse (F 5 A/250V, 2110-0709) U.L. listed and CSA certified
- Europe (230 V orientation) Fuse (F 5.0A/250V, 2110-0709) IEC listed and U.L. recognized certified

## WARNING For continued protection against fire hazard replace line fuse only with same type and rating:

- United States—F 5A/250V, Part Number 2110-0709
- Europe—F 5A/250V, Part Number 2110-0709
- The use of other fuses or material is prohibited.

#### Figure 4 Line Fuse



#### **Test Set Interface**

Connection to the PNA Test Set I/O connector or from Pass Thru Interface from another Test Set.

#### **Pass Through Interface**

Connection to another Test Set's, Test Set Interface.

## System Setup

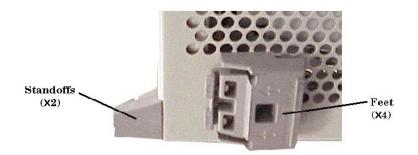
#### Attaching the Test Set to the PNA

This step is not necessary if you plan to place the Network Analyzer and Test Set in an equipment rack.

#### **Preparing the Network Analyzer**

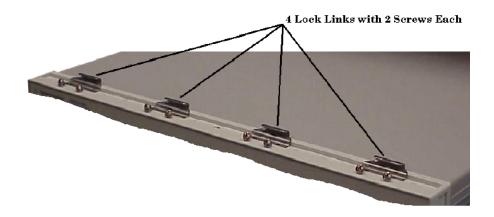
1. Remove feet from the bottom of the network analyzer.

#### Figure 5 Bottom Feet



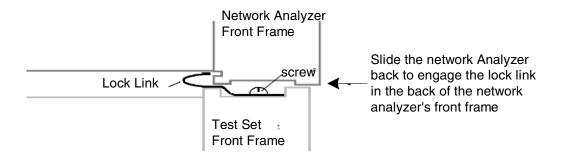
- 2. Remove screws (0515-1619) from the two lower rear panel standoffs.
- 3. Install the two rear locking feet where the standoffs were removed. Use rear brackets (Z5623-20239) on the right side and (Z5623-20240) on the left side of the analyzer. Use the two longer screws (0515-0686) to secure the feet to the analyzer.
- 4. Remove the front frame trim strip from Test Set.
- 5. Install the four lock links (1600-1423) on the top of the front frame, using 8 screws (0515-1499).

#### Figure 6 Lock Links



6. Place the network analyzer on top of the Test Set and ensure that the front frame of the network analyzer is positioned slightly forward of the locks that are attached to the Test Set. Slide the network analyzer back so the locks engage the front frame of the analyzer.

Figure 7 Locking the Analyzer's



7. Secure the network analyzer's lower locking feet to the Test Set upper locking feet, using two short screws (2680-0179), one on the each side of the instrument as shown Figure 8. If the network analyzer's lower locking feet are not aligned with the screw holes in the Test Set's upper locking feet, loosen the screws securing the feet to the instrument slightly to align.

#### Figure 8 Locking Feet Screws



8. Tighten all of the screws.

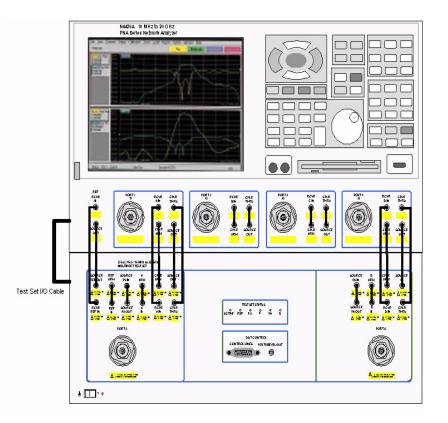
#### **RF** Cable Connections

Figure 9 on page 17 shows the setup configuration of the Z5623AK64 High Power Test Set and how it should be configured to the N5230A 4-Port PNA-L Series Network Analyzer.

1. Connect the cables as listed in Table 7.

| RF Cables   | From (PNA)                | To (Test Set)  |
|-------------|---------------------------|----------------|
| Z5623-20418 | Port Reference SOURCE OUT | SOURCE REF OUT |
| Z5623-20418 | Port 1 CPLR ARM           | CPLR ARM       |
| Z5623-20418 | Port 1 SOURCE OUT         | SOURCE OUT     |
| Z5623-20418 | Port 4 CPLR ARM           | CPLR ARM       |
| Z5623-20418 | Port 4 SOURCE OUT         | SOURCE OUT     |
| Z5623-20419 | Port Reference RCVR IN    | RCVR REF IN    |
| Z5623-20419 | Port 1 RCVR A IN          | RCVR A IN      |
| Z5623-20419 | Port 1 CPLR THRU          | CPLR THRU      |
| Z5623-20419 | Port 4 RCVR D IN          | RCVR D IN      |
| Z5623-20419 | Port 4 CPLR THRU          | CPLR THRU      |

Table 7Cable Connection



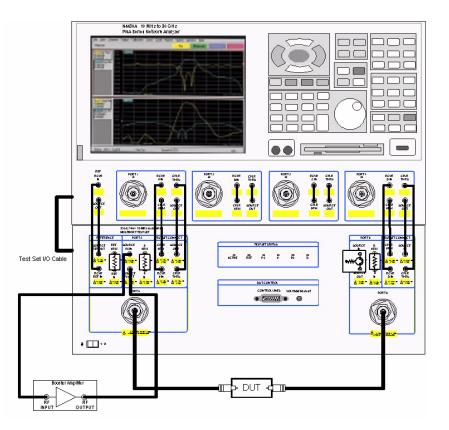
#### Figure 9 Z5623AK64 Setup Configuration

2. Connect Test Set I/O cable (8120-6818), supplied, between the PNA-L and the Z5623AK64 Test Set Interconnect on the rear panel. Do not connect this to the Z5623AK64 Pass Thru Interconnect.

### **High Power System Setup**

**CAUTION** A high power isolator or attenuator MUST be inserted at the P6 SOURCE OUT and SOURCE IN front panel connectors to protect the internal test set switch and PNA solid-state transfer switch. 20 dB of minimum isolation is recommended. Optimum power level to all PNA receivers is -15 dBm. Insert the attenuators to the receivers (A, D and REF) to reduce power accordingly. Set the initial instrument state to -65 dBm test port power level to reduce risk of damage when turning on the unit.

#### Figure 10 High Power Forward Direction



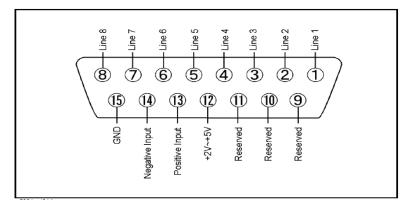
## **DUT Control**

#### Setting the Control Line

This section describes the electrical characteristics of the control line, connection to a DUT and an external dc power supply. For more information regarding the control lines refer to Table 12 on page 32.

#### **Pin Assignment**

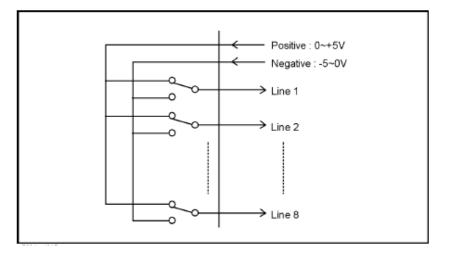
#### Figure 11 Pin Assignment for the Control Line



| Pin Number | Signal Name    | Description  |  |
|------------|----------------|--|--|
| 1          | Line 1         | output port of line 1  |  |
| 2          | Line 2         | output port of line 2  |  |
| 3          | Line 3         | output port of line 3  |  |
| 4          | Line 4         | output port of line 4  |  |
| 5          | Line 5         | output port of line 5  |  |
| 6          | Line 6         | output port of line 6  |  |
| 7          | Line 7         | output port of line 7  |  |
| 8          | Line 8         | output port of line 8  |  |
| 9          |                | not used   |  |
| 10         |                | not used   |  |
| 11         |                | not used   |  |
| 12         | +2 V to +5 V   | The voltage input to pin 13. (The voltage<br>can be varied by rotating the voltage<br>adjustment trimmer on the front panel).  |  |
| 13         | Positive Input | Input a signal that is outputted when each<br>line is high from the pin 12 or external dc<br>power supply.   |  |
| 14         | Negative Input | Input a signal that is outputted when each<br>line is low from the external dc power<br>supply. Able to output 0 V as low from the<br>each line by connecting to pin 15. |  |
| 15         | Gnd            | ground terminal  |  |

Table 8Pin Assignment

#### Figure 12 Block Diagram of DUT Control



## Table 9Specifications

| Item                      | Specifications                 |  |
|---------------------------|--------------------------------|--|
| Connector Shape           | 10-pin female D-Sub            |  |
| Voltage Range:            |                                |  |
| Positive Input            | 0 to +5 V                      |  |
| Negative Input            | -5 to 0 V                      |  |
| Maximum Current           | 100 mA (in total of each line) |  |
| Impedance                 | < 10 Ω                         |  |
| Range of Variable Voltage | +2 to +5 V                     |  |

#### Setting the Voltage of the Variable Voltage Output

The output voltage of pin 12 can be varied from +2 to +5 V. Perform the following procedure to set the voltage:

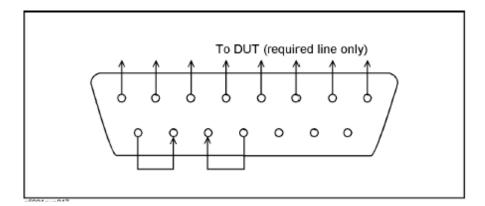
- 1. Turn On Z5623AK64.
- 2. Measure the voltage between pin 12 and 15 using a multimeter.
- 3. Rotate the voltage adjustment trimmer on the front panel until the multimeter indicates the appropriate voltage.

#### **Connect to the DUT**

Figure 13 shows an example of the connection between the DUT and the Z5623AK64 *without* an external dc power supply. Input the signals from pin 12 and 15 to the Positive Input and Negative Input respectively and connect each line to the control terminal of the DUT.

**CAUTION** The path that can be shorted is between pin 12-13 and the pin 14-15 only. Damage may result if any other path is short-circuited.

#### Figure 13 Connecting to the DUT

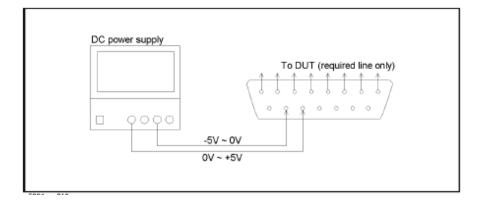


#### Connecting to the DUT With an External dc Power Supply

Figure 14 shows an example of the connection between the DUT and the Z5623AK64 with an external dc power supply. Input the High and Low signals from the external power supply to the Positive Input and Negative Input respectively, and connect each line to the control terminal of the DUT.

**CAUTION** Do not short-circuit between the pins, it may cause damage.

#### Figure 14 Z5623AK64 to the DUT and External Power Supply



# **Controlling the Test Set**

The Z5623AK64 High Power Test Set is considered a "slave" instrument. The PNA-L must used to control the Test Set. There are three methods to control the Test Set. Methods 1 and 2 will be explained in this manual. Refer to the standard PNA manual for the third method.

- The PNA Interface Control.
- The PNA GPIB Command Processor.
- External Test Set I/O connector through SCPI and COM programming commands. Refer to the standard PNA manual.

# **Key Conventions**

The following key conventions are used throughout this document.

- [HARDKEYS] are labeled front panel keys
- **SOFTKEYS** are unlabeled keys whose function is indicated on the instrument display

## **PNA Interface Control**

The Interface Control feature allows remote commands and data to be send to the following PNA rear-panel Interfaces: GPIB, Material Handler I/O, Test Set I/O, and Auxiliary I/O.

This section includes only the features required in the Interface Control for the Z5623AK64 High Power Test Set. Applications and feature information, such as those listed below, can be found in the PNA's Help Menu listed under "Interface Control."

- Overview
- How to Access Interface Control Settings
- Interface Control Dialog Box
- Z5326A H08 Test Set Commands
- Other Connectivity Topics

#### Overview

The Interface Control feature also allows you to send data to control external Test Set without needing to create a remote program. The PNA manages the timing and required interface setup.

A unique set of control data can be sent for each channel. In addition, a unique set of control data can be sent before the channel sweep starts and after the sweep ends.

Interface Control settings can be saved and recalled from the Interface Control dialog box or with instrument state **Save** and **Recall**.

Control data can only be WRITTEN to the interfaces, NOT READ from the interfaces.

Control data is sent in the following order and *cannot* be changed.

- 1. GPIB Interface
- 2. Material Handler Interface
- 3. Test Set Interface
- 4. Aux Interface
- 5. Dwell Time

| <u>Channel</u> Sw <u>e</u> ep Calibra                  |  |
|--|--|
| Start/Stop   |  |
| <u>C</u> enter/Span                                    | Interface Control  |
| C <u>W</u> Frequency                                   | C Enable Interface Control   |
| Frequency Offset                                       | Channel 1 Channel Control Label:   |
| Power  | Before Sweep Start After Sweep End   |
| <u>–</u><br><u>R</u> estart Average<br><u>A</u> verage | GPIB Commands - BEFORE   |
| Advanced   | <u></u>  |
| Interface Control                                      | Handler I/O Control Test Set I/O Control (addr.data)   |
| C <u>h</u> annel 🎋                                     | Enable Control     Enable Control  |
| C <u>o</u> py Channel                                  | Port A (0-255)   |
| Test Set   | Port B (0.255)   |
| 1050000  | Port C [U-15] Port D [0-15] Port D [0-15] F Enable Control   |
|  | Dwell After Command         DAC1         (+10V → +10V)           ms         DAC2         (+10V → +10V) |
|  | Reset All Save Recall OK Cancel Help   |

An instrument **Preset** will reset all of the fields to their default settings.

**NOTE** If an error is encountered when sending Interface Control data, an error message is displayed on the PNA screen. The Channel Trigger State is set to Hold. You must fix the condition that caused the error, then change the Channel Trigger State to its original setting.

#### **Enable Interface Control:**

Enables and disables ALL Interface Control communication. When cleared (default setting) Interface Control is disabled and NO data is sent. To send data, the individual interfaces must also be enabled.

#### Channel:

Specifies the channel number for dialog settings. Each channel is configured individually. The list box shows the channels that currently have measurements. There must be at least one measurement present in order to make the settings.

#### Channel Label:

Specifies the label to be displayed on the PNA screen during the channel sweep.

Before Sweep Start - After Sweep End Tabs.

**NOTE** While using Interface Control, the PNA must be in GPIB System Controller mode. Once this is complete you must restart the PNA application to go back to Talker/Listener.

Commands /data for all four interfaces can be sent both Before Sweep Start and After Sweep End. However, they are configured and enabled on separate tabs of the Interface Control dialog box. For example, to send GPIB commands both Before and After a PNA sweep, the Enable Control check box must be selected and commands entered on BOTH the Before Sweep Start and After Sweep End tabs.

#### **Before Sweep Start:**

The data is sent BEFORE the first trace on the channel begins sweeping.

#### After Sweep End:

The data is sent AFTER the last trace on the channel completes sweeping.

#### Test Set I/O

#### **Enable Control:**

Enables and disables sending data out of the External Test Set I/O connector.

#### **Multi-line Edit Control:**

Each line contains a Write command using the following syntax:

address: any positive integer

value: any positive integer

Address and value are separated by a period, for example:

 $0.2 \\ 16.127$ 

Entries should be separated by a new line or carriage return. The PNA front-panel **[Enter]** key inserts a new line into the field. All entries are sent out the External Test Set I/O using the WriteData Method. The number of entries is limited only by the available memory of the PNA.

#### **Dwell After Command:**

Specifies a wait time, in milliseconds, after all commands to all interfaces are sent. Any positive integer is allowed. This is used to allow all external devices to settle before beginning a measurement. An erratic trace could indicate that more settling time is necessary.

#### **Reset All:**

Sets ALL fields on ALL channels to their default values.

#### Save and Recall

Saves and recalls the contents of the dialog box. If the Interface Control dialog box is populated with settings during an Instrument State Save, the settings are automatically recalled with the instrument state settings. Interface control uses an \*.xml file type. An example file is stored on the PNA hard drive. You can recall it into the dialog, or you can open and edit it with a word processor, such as Word Pad.

#### OK:

Applies the settings and closes the dialog box.

#### Cancel:

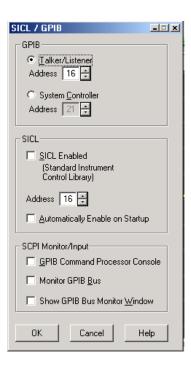
Does not apply changes that were made and closes the dialog box.

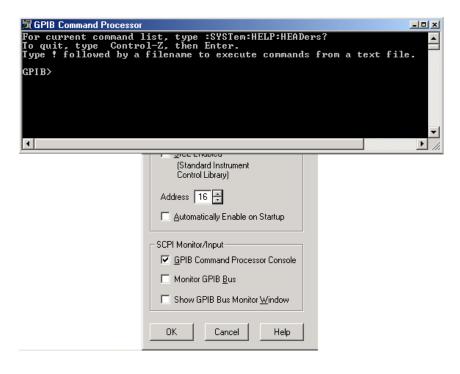
**NOTE** Z5623AK64 Test Set I/O Commands can be found in Table 10 on page 30. The Address and Data commands can be entered into the Test Set I/O control.

## **PNA GPIB Command Processor**

To control the Z5623AK64 Test Set through the GPIB Command Processor press [Menu/Dialog] then tab to System, select Configure > SICL/GPIB and check the GPIB Command Processor Console box.

|                     |                     | -8 ×                 |
|---------------------|---------------------|----------------------|
| ale M <u>a</u> rker | System Window Help  | ·                    |
| Hz 🗧                | <u>P</u> reset      | Center Span          |
|                     | <u>U</u> ser Preset |                      |
|                     | Security            | 202                  |
|                     | <u>C</u> onfigure ► | SICL/GPIB            |
|                     | Macro 🕨             | Control Panel        |
|                     | Windows Taskbar     | System Z0            |
|                     | <u>K</u> eys        | Power Meter Settings |
|                     | Service +           |                      |
|                     |                     |                      |





#### Write Commands

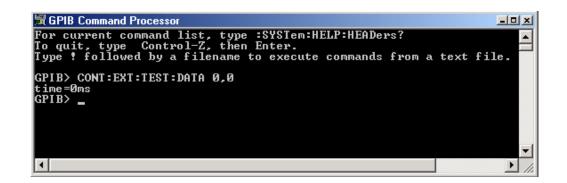
Once the GPIB Command Processor Console is open, commands can remotely control the external Test Set I/O connector by sending the following:

CONTrol:EXTernal:TESTset:DATa<addr>,<data>

Parameters:

- <addr> Decimal equivalent of the 13 bit binary address
- <data> Decimal equivalent of the 13 bit binary data

#### Example: CONT:EXT:TEST:DATA 0,0



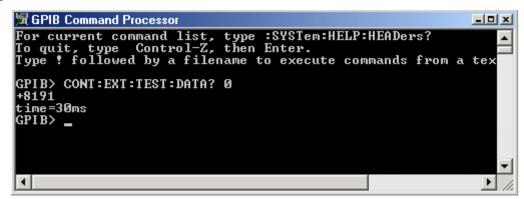
#### **Read Commands**

CONTrol:EXTernal:TESTset:DATa<addr>,<data>

Parameters:

<addr> Decimal equivalent of the 13 bit binary address

#### Example: CONT:EXT:TEST:DATA? 0



Reads the decimal equivalent of the binary data from the specified address.

## Test Set I/O Interface Commands

#### **Switch Address and Data**

Table 10 and Table 11 contain the information to set the internal switch paths of the Z5623AK64 Test Set. For more information about the internal switches refer to "Theory of Operation" on page 48.

|--|

| Test Set I/O Address and Data Switch |                 | and Data Switch                         |   |   |
|--------------------------------------|-----------------|---|---|---|
| Address                              | Data<br>(Value) | Data<br>AD12-AD0                        | Description   | <b>Bit Data</b><br>0=internal<br>1=external |
| 0                                    | 0               | 000000000000000000000000000000000000000 | Sets test set into bypass mode or internal                              |   |
| 0                                    | 31              | 000000011111                            | Sets test set into high power mode or external for forward measurements |   |
| 0                                    | 15              | 000000001111                            | Sets test set into high power mode or external for reverse measurements |   |
| 0                                    |                 | 00000000xxxxB                           | Bit 0 controls Port 1 and 5 source switch SW1                           | 0,1   |
| 0                                    |                 | 00000000xxxBx                           | Bit 1 controls Port 1 and 5 receiver switch SW2                         | 0,1   |
|                                      |                 | 00000000xxBxx                           | Bit 2 controls Port 4 and 6 source switch SW3                           | 0,1   |
| 0                                    |                 | 00000000xBxxx                           | Bit 3 controls Port 4 and 6 receiver switch SW4                         | 0,1   |
| 0                                    |                 | 0000000Bxxxx                            | Bit 4 controls reference switch SW5                                     | 0,1   |
| x indicate                           | es unknowr      | n user bit state                        |   |   |
| B indicate                           | es bit of int   | terest                                  |   |   |

#### Table 10Test Set Switch Address and Data

There are 32 individual switch combinations for the Z5623AK64. To select a Test Set switch configuration, all 5 switches must be set. To do this you must add AD4 to AD0 binary number and convert this to a decimal equivalent. Refer to Table 11 on page 31.

| Address 0         |   | Bit Decimal Equivalent |  |   | 16  | 8   | 4   | 2   | 1   |
|-------------------|---|------------------------|--|---|-----|-----|-----|-----|-----|
| SW Data = 0 to 31 |   |                        |  |   | AD4 | AD3 | AD2 | AD1 | AD0 |
| Switch            |   |                        |  |   | SW5 | SW4 | SW3 | SW2 | SW1 |
| 0                 | Add bits AD4 to $AD0 = 0$                                 |                        |  | 0 | 0   | 0   | 0   | 0   |     |
| 31                | Add bits AD4 to AD0 = 31                                  |                        |  | 1 | 1   | 1   | 1   | 1   |     |
| 12                | 2 Example:<br>SW5, SW2, SW1 internal, SW ELSE<br>external |                        |  | 0 | 1   | 1   | 0   | 0   |     |

#### Table 11 Switch Address and Data Example

#### **Control Lines**

Table 12 and Table 13 contain the information to set the control lines of the Z5623AK64 Test Set. Refer to "DUT Control" on page 19 for more information.

| Table 12 Test Set DUT Control Addre | ress and Data |
|-------------------------------------|---------------|
|-------------------------------------|---------------|

| Test Set I/<br>Control Li |                 | and Data DUT                            |   |   |
|---------------------------|-----------------|---|---|---|
| Address                   | Data<br>(Value) | Data<br>AD12-AD0                        | Description                                 | <b>Bit Data</b><br>0= + internal<br>1= - external |
| 16                        | 0               | 000000000000000000000000000000000000000 | All DUT Control Lines set to 0 or + voltage |   |
| 16                        | 225             | 0000001111111                           | All DUT Control Lines set to 1 or – voltage |   |
| 16                        |                 | 00000xxxxxxB                            | DUT Control Line 1                          | 0,1   |
| 16                        |                 | 00000xxxxxBx                            | DUT Control Line 2                          | 0,1   |
| 16                        |                 | 00000xxxxxBxx                           | DUT Control Line 3                          | 0,1   |
| 16                        |                 | 00000xxxxBxxx                           | DUT Control Line 4                          | 0,1   |
| 16                        |                 | 00000xxxBxxxx                           | DUT Control Line 5                          | 0,1   |
| 16                        |                 | 00000xxBxxxxx                           | DUT Control Line 6                          | 0,1   |
| 16                        |                 | 00000xBxxxxxx                           | DUT Control Line 7                          | 0,1   |
| 16                        |                 | 00000Bxxxxxxx                           | DUT Control Line 8                          | 0,1   |
| x indicates               | unknown u       | iser bit state                          | ·   |   |
| B indicates               | s bit of inter  | est                                     |   |   |

There are 256 individual DUT control line combinations for the Z5623AK64. To select a Test Set DUT control line configuration, all 8 DUT control lines must be set. To do this you must add AD7 to AD0 binary number and convert this to a decimal equivalent. Refer to Table 13 on page 33.

| Address 16             |   |        |        |        |        |        |        |        |        |
|------------------------|---|--------|--------|--------|--------|--------|--------|--------|--------|
| Bit Decimal Equivalent |   | 128    | 64     | 32     | 16     | 8      | 4      | 2      | 1      |
| DUT Data = 0 to 255    |   | AD7    | AD6    | AD5    | AD4    | AD3    | AD2    | AD1    | AD0    |
| Control Lines          |   | Line 8 | Line 7 | Line 6 | Line 5 | Line 4 | Line 3 | Line 2 | Line 1 |
| 0                      | Add bits AD7 to<br>AD0 = 0  | 0      | 0      | 0      | 0      | 0      | 0      | 0      | 0      |
| 255                    | Add bits AD7 to<br>AD0 = 255  | 1      | 1      | 1      | 1      | 1      | 1      | 1      | 1      |
| 85                     | Example:<br>DUT8, DUT6,<br>DUT4, DUT2<br>+ Voltage<br>DUT ELSE<br>- Voltage | 0      | 1      | 0      | 1      | 0      | 1      | 0      | 1      |

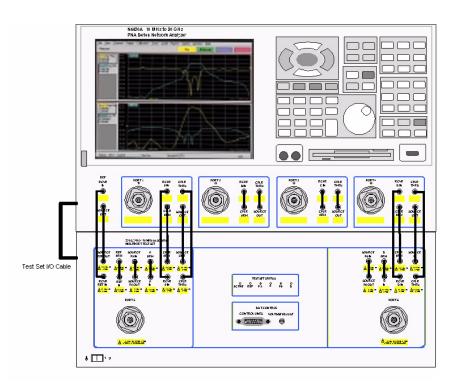
#### Table 13 DUT Control Address and Data Example

# **High Power Measurements With Z5623AK64**

The Z5623AK64 and N5230A 4-Port PNA-L with Option 245 can be configured to measure high power devices. This ability is useful if the required power for the device under test is greater than what analyzer can provide, or if the maximum output power from the amplifier under test exceeds safe input limits for the analyzer. This section describes how to set up the analyzer and test set to perform high power measurements.

# **Initial Setup**

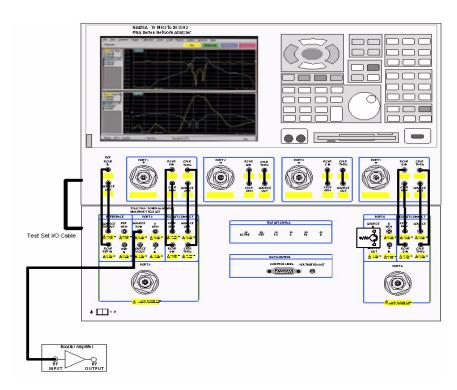
1. Connect the Test Set to the PNA. See Figure 15. All equipment should be turn off at this time. Connect the jumpers between the Test Set and the PNA for both 1 and 5, 4 and 6 and the Reference Access ports.



#### Figure 15 Setup Configuration

- 2. Remove the jumpers on the front panel of the Test Set if the Z5623AK64 is in the shipped mode configuration (all the jumpers are still on).
- 3. Connect the booster amplifiers RF Input connector to the SOURCE P5 IN access connector on the front panel of the Z5623AK64. Ensure that the amplifier is turn Off at this time.

4. Place an isolator or attenuator between the SOURCE P6 IN and SOURCE P6 OUT on the port 2 side. The isolators placement is important to ensure that the signal is attenuated into SOURCE P6 IN. The reverse attenuation or isolation factor of the isolator should be 20 dB or greater.



#### Figure 16 Connect Booster Amplifier

## **Determining Power Levels**

Before continuing, save this state and set it up as the **User Preset**. The User Preset Conditions can be found in the PNA Series Network Analyzer Help System. Press [Menu/Dialog] then tab to Help > Network Analyzer Help. Type in User Preset. The final state can then be re-saved as the User Preset to avoid an over power condition from the factory preset. To find the User Preset press [Menu/Dialog] then tab to System, select User Preset and check User Preset Enable. Click Save current state as User Preset > OK.

- 5. Turn On the analyzer and Test Set and reduce the power level to -20 dBm by pressing **[Menu/Dialog]** then tab to **Channel** and select **Power**. Enter **[-20]** in the Test Port Power entry area. Port Power Coupled should be checked to ensure that ports 1 and 2 power levels are the same. Un-Couple ports should be used when adjusting the S12 power level to a different power level from Port 1.
- 6. Set the Z5623AK64 Test Set so the external booster amplifier is in the RF path. See Test Set I/O Interface Commands Table 10 on page 30 and Table 11 on page 31 to set the Test Set switches to external. This will place the booster amplifier in the RF path.
- 7. Turn On the booster amplifier.
- 8. Using a high power meter and sensor, measure the output power from the booster amplifier RF Output.

| NOTE | Additional attenuation may have to be added between the coupler and the |
|------|---|
|      | power meter depending on the power used.                                |

- 9. Verify the gain of the booster amplifier(s). For example; if the analyzer output power level was set to -20 dBm and the output power measured from the open end of the coupler was -5 dBm, the gain of the booster amplifier would be +15 dB.
- 10. Verify that the power measured in the previous step is within the acceptable limits (less than +43 dBm for the SOURCE P5 OUT port).
- 11. Turn Off the booster amplifier.
- 12. Estimate the maximum power level that will be needed to force the DUT into compression. Acceptable limits are less than +43 dBm for the SOURCE P5 OUT port.
- **CAUTION** Do not command the Test Set to engage or disengage the amplifier from the Port 1 RF path while the amplifier is on. This can damage the internal RF switches in the Test Set.
- 13. Connect the booster amplifier RF OUTPUT connector to the SOURCE P5 OUT connector on the front panel of the Z5623AK64. Ensure that the amplifier is turned Off at this time.

- 14. Turn On the booster amplifier.
- 15. Measure the output power from the Test Set's REF ARM port, using a high power meter and sensor.
- 16. Turn Off the booster amplifier.
- 17. Measure the output power from the Test Set's A ARM port, using a high power meter and sensor.
- 18. Turn Off the booster amplifier.
- 19. Estimate the maximum power level that will be needed to force the DUT into compression.

### **Selecting Power Ranges and Attenuator Settings**

- 20. Select a PNA power range that will not exceed the maximum estimated power level, but will force the DUT into compression. For example; if your booster amplifier has a gain of +15 dB and the DUT will compress if supplied with +15 dBm, then adjust the analyzer's output power not to exceed +0 dBm. Select [Menu/Dialog] then tab to Channel, select Power > uncheck Auto and enter [10] into the entry area. The Port Power Coupled can be verified to ensure that Port 1 and 2 power levels are the same, or uncoupled if Port 1 and 2 power level requirement are different.
- 21. Estimate the maximum amount of gain that could be provided by the DUT and as a result, the maximum amount of power that could be received by Test Port 6 when the DUT is in compression. For example; if a DUT with a maximum gain of +10 dB receives an input of +10 dBm, the maximum amount of power that could be received by Test Port 6 is +20 dBm. An isolator or attenuator may be required depending on the amount of power at Test Port 6. An isolator can be placed between the Test Set's SOURCE P6 OUT and SOURCE P6 IN to protect the Test Set and the PNA. The isolators placement is important to ensure that the signal is attenuated looking into SOURCE P6 IN. The reverse attenuation or isolation factor of the isolator should be 20 dB or greater.
- 22. Calculate the amount of attenuation needed so that the optimum PNA receiver power level of -15 dBm is not exceeded. Refer to your PNA specifications to optimize power levels to the receiver ports.

In following example it will be necessary to take the following into consideration:

- Measured at the Test Set's REF ARM = -2 dBm.
- Estimated compression power = -2 dBm
- The optimum PNA receiver power level is -15 dBm.
- Loss thru the REF switch and cables in the Test Set is approximately 3 dB.

With the previous points in mind, the amount of attenuation can be calculated from the following equations:

- Attenuator REF ARM setting = -2 dBm (-15 dBm) (-3 dB) = 10 dB
- REF ARM attenuator value = 10 dB
- 23. Place the attenuator(s) on Test Set's REF ARM to the value calculated in step 22.
- 24. Turn On the booster amplifier.
- 25. Measure the output power from the Test Set's REF ARM, using a high power meter and sensor.
- 26. Verify that the power measured in the previous step is within the acceptable limits (-12 dBm the RCVR REF IN).
- 27. Calculate the amount of attenuation needed so that the optimum PNA receiver power level of -15 dBm is not exceeded. Refer to your PNA specifications to optimize power levels to the receiver ports.

In the following example it will be necessary to take the following into consideration:

- Measured at the Test Set's A ARM = -2 dBm.
- Estimated compression power = -2 dB.
- The optimum PNA receiver power level is -15 dBm.
- Loss thru the A switch and cables in the Test Set is approximately 3 dB.

With the previous points in mind, the amount of attenuation can be calculated from the following equations:

- Attenuator A ARM setting = -2 dBm (-15 dBm) (-3 dB) = 10 dB
- A ARM attenuator value = 10 dB
- 28. Place the attenuator (s) on Test Set's A ARM to the value calculated in step 27.
- 29. Turn On the booster amplifier.
- 30. Measure the output power from the Test Set's A ARM, using a high power meter and sensor.
- 31. Verify that the power measured in the previous step is within the acceptable limits (-12 dBm to A IN).
- 32. Calculate the amount of attenuation needed between the D ARM and D IN coupler and receivers not exceed the optimum receiver power level of -15 dBm.

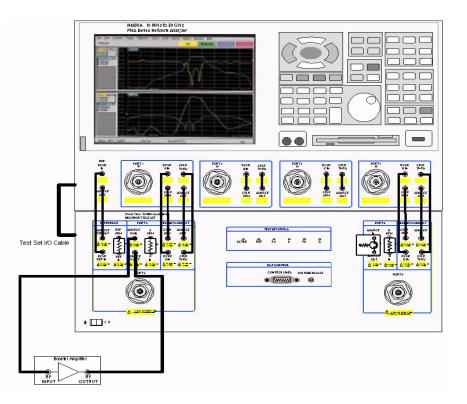
In this example, it will be necessary to take the following into consideration:

- Power to Test Port 6 is 40 dBm.
- D ARM will be coupled from Test Port 6.
- The coupling factor of Test Port 6 is 13 dB.
- The optimum receiver power level is -15 dBm.
- Loss thru the D RCVR switch and cables in the Test Set is approximately 3 dB

With the previous points in mind, the amount of attenuation can be calculated from the following equations:

- Attenuator D ARM setting = +40 dBm 13 dB (-15 dBm)(-3 dB) = 45 dB
- D ARM attenuator value = 45 dB

33. Place the attenuator (s) on Test Set's D ARM to the value calculated in step 32.



#### Figure 17 Booster Amplifier, Attenuators and Isolator Placement

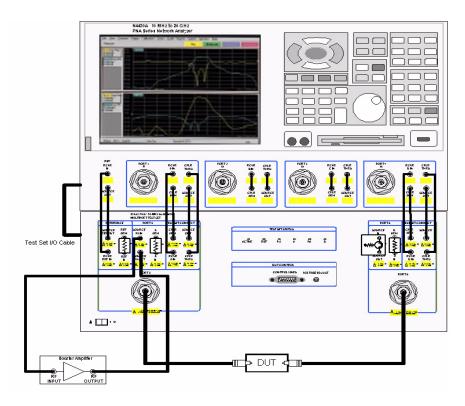
- 34. Turn On the booster amplifier.
- **CAUTION** Do *not* press Preset unless you have turned Off the booster amplifier(s) or have saved this state and renamed it to User Preset. Pressing Preset will return the analyzer to its default power level and default internal attenuator settings. The increase in power may result in damage to the DUT or analyzer.
- 35. Measure the output power from test Port 1 using a high power meter and verify that it is as expected.
- 36. High power isolators should be inserted between the SOURCE OUT and CPLR IN front panel ports on the Test Set if you are measuring a highly reflective device.

# **Final Setup**

- 37. Confirm that all power and attenuator settings are correct and set the following measurement: Press [Menu/Dialog] then tab to Trace, select Measure > S21.
- 38. Perform a response calibration:
  - Connect the test port cables to form a thru configuration.
  - Press [Menu/Dialog] then tab to Calibration, select Calibration Wizard > Unguided Calibration Use Mechanical Standards > Next > THRU Response > Next. Follow analyzers window prompts to finish calibration.

39. Make the connection as shown in Figure 18. Turn on the DUT and measure the S21 gain of the amplifier under test to confirm the proper operation of the measurement test setup.

#### Figure 18 Connect the DUT



40. Make any other desired high power measurements.

- Ratio measurements, such as gain, will be correctly displayed. However, the displayed absolute power levels on the analyzer will *not* be correct. To correctly interpret power levels, gain of the booster amplifier and attenuator values must be taken into consideration.
- **NOTE** At this time a Full 2 or 4 port calibration cannot be performed in the High Power mode. To perform a Full 2 or 4 port calibration the PNA must have N-port firmware to control the reference channel of the Test Set.

If no calibration has been performed or if the instrument is in an un-calibrated state, the following must be taken into consideration when interpreting the measured data:

- The value of attenuation added to receiver A and D.
- The R channel reference level supplied from the Test Set.
- Protection of the internal parts for the Test Set and PNA.

# **Test Set Internal Configurations**

The Z5623AK64 can be internally configured to allow different application requirements. This section describe the Test Set's internal configurations.

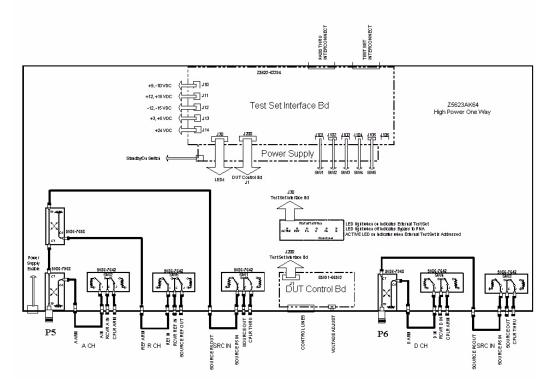
There are two basic mode configurations.

- Bypass
- High Power

# **Bypass**

The bypass mode sets the Test Set's internal switches so that the source, receiver and reference are all directed to the PNA. Figure 19 shows each switch path. Each switch has been set so information received from the PNA is directed back to the PNA. All 4 ports of the PNA are operational. Figure 20 on page 43 shows the paths of the PNA and Test Set.

#### Figure 19 Bypass



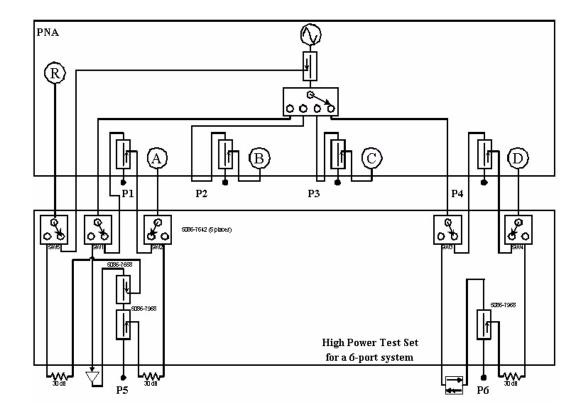


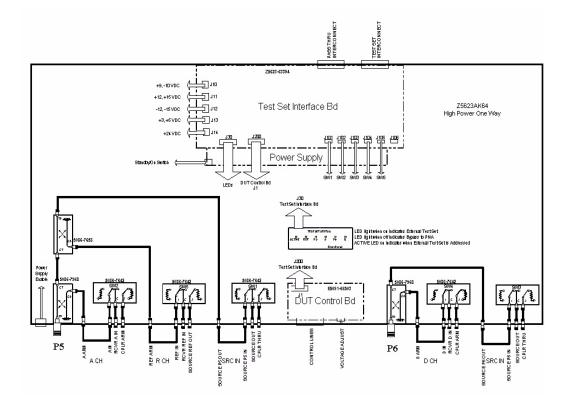
Figure 20 PNA and Test Set in Bypass

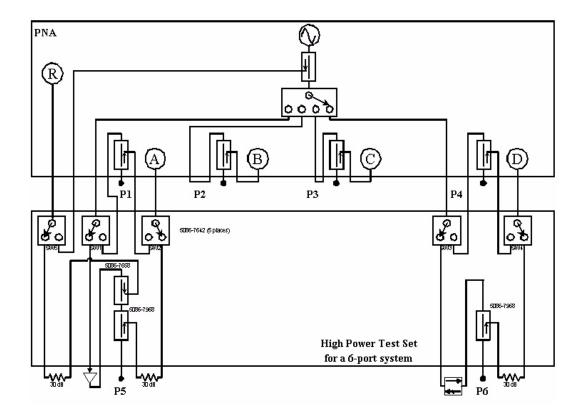
#### General Information Test Set Internal Configurations

## **High Power**

The high power mode sets the Test Set's internal switches so that the source, receiver and reference are all directed to the Test Set. Ports 1 and 4 of the PNA are non operational in this configuration. Each switch shown in Figure 21 are now engaged for the high power forward measurements. Figure 22 on page 45 shows the paths of the PNA and Test Set.

#### Figure 21 High Power





### Figure 22 PNA and Test Set High Power

# Specification

Specifications for the Z5623AK64 High Power Test Set are nominal. System performance for the PNA and Test Set are not provided. A functional certificate is only offered for the Z5623AK64.

| NOTE | Nominal specifications are based on 1 to 2 unit's performance.   |
|------|--|
| NOTE | This Test Set, when connected to a PNA, will degrade the performance of the test ports that the Test Set interconnects to. The internal solid-state switch paths reduce Test Port power and power to the receiver ports. This affects not only the test port power of the PNA and also reduces dynamic range. Test Port power of the PNA will be reduced as much as 10 dB and power to the receivers will be reduced by as much as 10 dB. This will decrease the dynamic range by 20 dB. |

# **Declaration of Conformity**

For a copy of the manufacturer's Declaration of Conformity for this apparatus, contact your local Agilent Technologies office or sales representative on Page 59.

# Servicing the Z5623AK64 High Power Test Set

### **Service Information**

Return to Agilent Technologies factory for servicing or repair. Refer to "Contacting Agilent" on page 59.

| WARNING | No operator serviceable parts inside. Refer servicing to qualified personnel. To prevent electrical shock do not remove covers.  |
|---------|--|
| WARNING | These servicing instructions are for use by qualified personnel only.<br>To avoid electrical shock, do not perform any servicing unless you<br>are qualified to do so. |

## **Shipping Instructions**

You must always call the Agilent Technologies Instrument Support Center to initiate service before retuning your instrument to a service office. See "Contacting Agilent" on page 59. Always transport or ship the instrument using the original packaging if possible. If not, comparable packaging must be used. Attach a complete description of the failure symptoms.

# **Theory of Operation**

# **RF** Components

#### SW1 through SW5

SW1 through SW5 are all solid-state switches. Frequency range is 45 MHz to 20GHz.

#### SW1-Source to 1 and 5

SW1 of the Test Set directs the port 1 Source Out RF signal from the PNA by means of a jumper cable from the PNA port 1 and Test Set port SOURCE OUT access ports. When the Test Set is in the Bypass or Internal mode, SW1 directs the Source Out from the PNA to the Test Set CPLR THRU access port. The Test Set CPLR THRU access port is jumper cabled back to the PNA Port 1 CPLR THRU access port and provides the source output to Port 1 of the PNA. When the Test Set is in the high power or external mode, SW1 directs the Source Out to the Test Set's reference and test Port 5 couplers. This provides the source output for Port 5 of the Test Set.

#### SW2-Receiver A

SW2 directs the A Receiver signal from the PNA by means of a jumper cable from the PNA and Test Set RCVR A IN access ports. When the Test Set is in the Bypass or Internal mode, SW2 directs the A Receiver signal path from the PNA to the Test Set's CPLR ARM access port. The Test Set CPLR ARM access port is jumper cabled back to the PNA Port 1 CPLR ARM access port and provides the signal path from the PNA test Port 1 coupled arm. When the Test Set is in the high power or external mode, SW2 directs the A Receiver to the Test Set. This provides the signal path from the test Port 5 Coupled Arm.

#### SW3-Source to 4 and 6

SW3 of the Test Set directs the Port 4 Source Out RF signal from the PNA by means of a jumper cable from the PNA Port 4 and Test Set port SOURCE OUT access ports. When the Test Set is in the Bypass or Internal mode, SW3 directs the Source Out from the PNA to the Test Set CPLR THRU access port. The Test Set CPLR THRU access port is jumper cabled back to the PNA Port 4 CPLR THRU access port, and provides the source output to Port 4 of the PNA.When the Test Set is in the high power or external mode, SW3 directs the Source Out to the Test Set's reference and test Port 6 couplers. This provides the source output for Port 6 of the Test Set.

#### SW4-Receiver D

SW4 directs the D Receiver signal path from the PNA by means of a jumper cable from the PNA and Test Set RCVR D IN access ports. When the Test Set is in the Bypass or Internal mode, SW4 directs the D Receiver signal path from the PNA to the Test Set's CPLR ARM access port. The Test Set CPLR ARM access port is jumper cabled back to the PNA Port 4 CPLR ARM access port and provides the signal path from the PNA test Port 4 Coupled Arm. When the Test Set is in the high power or external mode, SW4 directs the D Receiver to the Test Set. This provides the signal path from test Port 6 Coupled Arm.

#### **Reference Coupler**

The reference coupler provides the REF channel a signal when the Test Set is in high power mode. This removes the effects the amplifier may induce on the signal such as drift and gain. This reference is only provided in the forward direction only P5 => P6. It can also be used making measurements from P5 to Port 2, 3 and 4 on the PNA. When the PNA is in the reverse measurement parameter capability the PNA internal REF must be used and the Test Set SW5 must be set to Bypass the Reference Coupler.

#### Test Port Couplers P5 and P6

The test port couplers are 3.5 mm male. The couplers can handle up to 40 watts of power to the test and coupler thru ports up to 20 GHz. These ports are use to measure the DUT for high power.

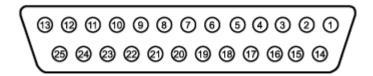
### **Test Set Interface Control**

Refer to the Test Set Interface Schematic while reading the following descriptions:

The Test Set I/O Interface board has Six sections. The first section is the Test Set Interface BD input. This section handles the Addressing, Data and Read/Write TTL instructions from the PNA Test Set I/O. A DB-25 female connector (J1 on the Test Set I/O Interface board) is located on the rear panel of the Test Set and receives external control commands from the PNA. All inputs are ESD protected by CR4 and CR5 on the Test Set Interface BD.

The PNA provides the appropriate timing signals needed for strobing the address and data lines. Below shows the Test Set Interface connector for the Z5623AK64. Pin numbers and locations are shown with a description of the pins used to control the Test Set.

#### Figure 23 Test Set I/O Interface (J1)



Address/Data I/O Pin Numbers 3, 4, 5, 6, 9, 10, 11, 17, 19, 20, 21, 22 and 23 Address and latched data

Test Set Select Bit SEL0, SEL1, SEL2, and SEL3 Pin Numbers 1, 15, 16, 18 Test Set select bits; tied to ground from the PNA.

LDS Pin Number 24 TTL output - active low data strobe

RLW Pin Number 25 TTL output - high-read, low-write

The high power Test Set is activated when the PNA sends a write command with the correct address. The address tells the Interface BD if the Test Set is being activated and which control section of the Interface BD to be used. After addressing the Test Set, PNA sends data and is left in the state they were issued. After a read command, PNA lines AD0-AD12 are left in input mode. While in this mode the Test Set sends it address to the PNA. AD0 - AD12 are addressable with in the high power Test Set. AD0 - AD12 can be configured within the Test Set to send the PNA a unique Test Set ID.

Below is the Test Set Read/Write figure showing how the PNA communicates (hand shakes) with the Test Set. More information about The PNA Test Set I/O connector can be found in the PNA series network analyzer online Help.

#### Figure 24 Test Set Write

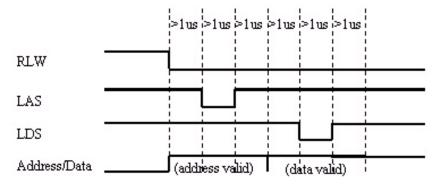
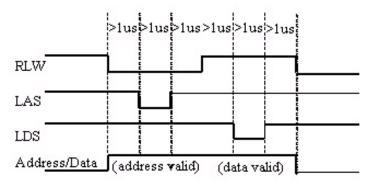


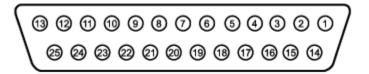
Figure 25 Test Set Read



The Test Set address depends on the input Test Set Select Bits. From the PNA, select bits are tied to ground. The first Test Set that connects to the PNA Test Set I/O connector is issued address 0. The Test Set uses these bits to determine if being addressed or not. The Test Set's Test Set Interface BD compares the select bits to the address from the PNA Test Set I/O. When the select bits match AD0-AD3 the Test Set becomes active. If the select bits do not match AD0-AD3 the Test Set is not active. The PNA address/data is 13 bits AD0-AD12. The Test Set address inputs is limited to 7 bits AD0-AD6. Address bits AD0-AD3 are dedicated to the Test Set address. Address bits AD4-AD6 determines what section the Test Set will communicate too.

The Pass Thru Interface connector on the rear panel of the Test Set passes the Address/Data, Strobes, and Interrupts from the PNA through the Test Set I/O Interface to the Pass Thru Interface. The Test Set Select bits are not directly pass through. The selected bits are received by the Test Set through the Test Set I/O Interface and incremented by the Address Val chip U40 and passed to the Pass Thru Interface. This sets the next Test Set address. Maximum number of Test Set's address allowed is 15.

#### Figure 26 Pass Thru Interface (J2)



Pass Thru Select Bit PSEL0, PSEL1, PSEL2, and PSEL3, Pin Numbers 1, 15, 16, 18 Pass Thru Test Set select bits; address issued by proceeding Test Set.

#### U40

When the Test Set's (J1) Test Set I/O Interface connector receives a command from the PNA, a Programmable Array Logic (PAL) IC U40 "Address Valid" interprets the address of the command. The Address Valid first determines if the command address AD0-AD3 matches the Select bits address. If the two address match the AOK bit goes high and signals the Test Set to be active and the address/data received is valid.

U40 also increments PSEL0-PSEL3 bits to the Pass Thru Interface. This is done by reading the Test Set I/O incoming Test Set select bits from either the PNA or Pass Thru from another Test Set.

U40 also reads AD4-AD6 when the AOK is high. A1-A4 is an address sent to the U2 "Data Valid" Programmable Array Logic (PAL) IC. This information determines what section of the Test Set Interface board is to be written too.

#### U41

Programmable Array Logic (PAL) IC U41 "Data Valid" interprets the address of A1-A4 and if the command is either a read or write. The Data Valid first determines if AOK is true. If AOK is true, U41 determines if the PNA is requesting or sending data to the Test Set by the state of RLW. When RLW is true the PNA is requesting information or read from the Test Set. When RLW is not true the PNA is send or writing data to the test.

The LDS provides the strobe to enable the outputs for WE1 though WE4.

When a read command is received the Data Valid PAL output pin RE enables U52 and U53 a tri-state buffer to set the AD0-AD12 data lines set by the S1 and S2 switches so the PNA can read the address. This is a unique address that the PNA can use to identify the Test Set with. This is for future use, but the address should be set so the first 8 bits AD0 through AD7 are set to decimal 83 or binary 01010011. This equals ascii character "S" for specials. The last 6 bits AD8 through AD13 will be set in binary only to indicate a order sequence the option. In this case this is the first option so the address will be set to decimal value 0 or binary 000000.

When a write command is received the Data Valid PAL A1-A4 are received and read from U40. These address lines determine what section or sections of the Test Set I/O Interface BD are to receive new information. The WE1 through WE4 are the write enable lines that enable sections 1-4. When the WE1-WE4 are high, data D0-D7 are past to the sections. WE1 enables section 1, WE2 section 2, WE3 section 3, and WE4 section 4.

#### U42

Programmable Array Logic (PAL) IC U42 "Data" pass eight data bits AD0-AD7 to all sections. Data is only passed when AOK is true, RLW is false, and when LDS is strobed. The outputs from this PAL are data lines D0 through D7 which are feed to sections 1-4. Currently this is being used as a latching circuit, but in the future this could be used to manipulate D I/O lines.

#### U43

Programmable Array Logic (PAL) IC U43 "LEDS" provides front panel stimulus. U43 deciphers AD0 through AD4 data bits along with a write enable bits WE1-WE4 to indicate the Test Set's internal state by LEDs on the front panel.

#### Section 1 through 4

Sections 1 through 4 are latches. These latches hold the data when the write enable WE is false or pass the data when their corresponding WE line is true.

#### Section 1

Section 1 controls all J1xx switches. J101 through J106 are used for SPDT 1X2 solid-state or mechanical switches J107 and J108 are used for 1X 4 solid-state switches. J109 is used for a 50 GHZ SPDT solid-state switch.

#### Section 2

Section 2 controls all J200 DUT Control and J201 through J202 1X 4 solid-state switches.

#### Section 3 - Not Used

Section 3 controls all J3xx attenuators and switches. J300 through J303 are used for attenuators. J304 and J305 are used for 1X 4 solid-state switches.

#### Section 4 - Not Used

Section 4 controls all J4xx AUX switches. J401 through J406 are used for SPDT solid-state or mechanical switches J407 and J408 are used for 1X 4 solid-state switches.

#### **Diagnostic LEDs**

The PC board has several diagnostic LEDs. Each power supply has its own LED to indicate that power is present. There are also LEDs to indicate if the Test Set is being talked to, if information is being requested, and which section is to receive data. Listed below are their reference designator and description.

| DS1  | Address | When the Test Set address matches the command address from the PNA, the LED is On. |
|------|---------|--|
| DS2  | WE2     | When data is set to section 2, the LED is On.                                      |
| DS3  | WE3     | When data is set to section 3, the LED is On.                                      |
| DS4  | Read ID | When the Test Set is requested to send data back to the PNA, the LED is Off.       |
| DS5  | WE1     | WE1 When data is set to section 1, the LED is On.                                  |
| DS6  | +5 VS   | When power is connected, the LED is On.  |
| DS7  | +24 VS  | When power is connected, the LED is On.  |
| DS8  | +3 VS   | When power is connected, the LED is On.  |
| DS9  | +12  VS | When power is connected, the LED is On.  |
| DS10 | +15  VS | When power is connected, the LED is On.  |
| DS11 | +9 VS   | When power is connected, the LED is On.  |
| DS12 | WE4     | When data is set to section 4, the LED is On; currently being used as Active LED.  |
| DS13 | -12  VS | -12 VS When power is connected, the LED is On.                                     |
| DS14 | –9 VS   | When power is connected, the LED is On.  |
| DS16 | -15  VS | When power is connected, the LED is On.  |

#### Front Panel LEDs

J30 on the Test Set I/O Interface BD connects to a ribbon cable with LEDs. These LEDs indicate the Test Set's internal state. When the LEDs are off, the Test Set is in a Bypass mode. All switches SW1-SW5 are set so the PNA is operating as a normal network analyzer. When the LEDs are all on, SW1-SW5 are set for the high power mode.

#### Line LED

The line LED comes ON when the front panel line switch is set to 1 position.

#### Active LED

The Active LED indicates if the Test Set is being talked to or that the last address was valid. When Lines WE1 through WE4 are true, then the Active LED is ON. When the PNA talks to another Test Set or if the Test Set is sent a wrong address the ACTIVE LED is OFF.

#### **REF LED**

The REF LED indicate if the Test Set SW5 is set to Bypass or High Power mode. When SW5 is in Bypass, the LED is OFF. In the high power configuration the LED is ON.

#### P5 LED

The P5 LED indicates if the Test Set SW1 is set to Bypass or High Power mode. When SW1 is in Bypass, the LED is OFF. In the high power configuration the LED is ON.

#### A LED

The A LED indicates if the Test Set SW2 is set to Bypass or High Power mode. When SW2 is in Bypass, the LED is OFF. In the high power configuration the LED is ON.

#### P6 LED

The P6 LED indicates if the Test Set SW3 is set to Bypass or High Power mode. When SW3 is in Bypass, the LED is OFF. In the high power configuration the LED is ON.

#### D LED

The D LED indicates if the test set SW4 is set to Bypass or High Power mode. When SW4 is in Bypass, the LED is OFF. In the high power configuration the LED is ON.

# Safety and Regulatory Information

# Introduction

Review this product and related documentation to familiarize yourself with safety markings and instructions before you operate the instrument. This product has been designed and tested in accordance with international standards.

# **Before Applying Power**

Verify that the product is configured to match the available main power source. If this product is to be powered by autotransformer, make sure the common terminal is connected to the neutral (grounded) side of the ac power supply.

# **Connector Care and Cleaning**

If alcohol is used to clean the connectors, the power cord to the instrument must be removed. All cleaning should take place in a well ventilated area. Allow adequate time for the fumes to disperse and moist alcohol to evaporate prior to energizing the instrument.

#### WARNING To prevent electrical shock, disconnect the Agilent Technologies model Z5623A from mains before cleaning. Use a dry cloth or one slightly dampened with water to clean the external case parts. Do not attempt to clean internally.

## **Compliance with Canadian EMC Requirements**

This ISM device complies with Canadian ICES-001. Cet appareil ISM est conforme a la norme NMB du Canada.

## **Compliance with German Noise Requirements**

This is to declare that this instrument is in conformance with the German Regulation on Noise Declaration for Machines (Laermangabe nach der Maschinenlaermrerordnung-3. GSGV Deutschland).

| Acoustic Noise Emission/Geraeuschemission |                      |  |  |
|---|----------------------|--|--|
| LpA<70 dB                                 | Lpa<70 dB            |  |  |
| Operator Position                         | am Arbeitsplatz      |  |  |
| Normal Operation                          | normaler Betrieb     |  |  |
| per ISO 7779                              | nach DIN 45635 t. 19 |  |  |

# Warnings

| WARNING    | The WARNING notice denotes a hazard. It calls attention to a<br>procedure, practice, or the like, which if not correctly performed or<br>adhered to, could result in personal injury. Do not proceed beyond a<br>WARNING notice until the indicated conditions are fully understood<br>and met.   |
|------------|---|
| Warnings a | applicable to this instrument are:  |
| WARNING    | If this product is not used as specified, the protection provided by<br>the equipment could be impaired. This product must be used in a<br>normal condition (in which all means for protection are intact) only.  |
| WARNING    | For continued protection against fire hazard replace line fuse only<br>with same type and rating:<br>• United States—F 5A/250V, Part Number 2110-0709<br>• Europe—F 5A/250V, Part Number 2110-0709<br>The use of other fuses or material is prohibited.   |
| WARNING    | This is a Safety Class I product (provided with a protective earthing<br>ground incorporated in the power cord). The mains plug shall be<br>inserted only into a socket outlet provided with a protective earth<br>contact. Any interruption of the protective conductor, inside or<br>outside the instrument, is likely to make the instrument dangerous.<br>Intentional interruption is prohibited. |
| WARNING    | The power cord is connected to internal capacitors that may retain<br>dangerous electrical charges for 5 seconds after disconnecting the<br>plug from its power supply.   |
| WARNING    | The opening of covers or removal of parts is likely to expose<br>dangerous voltages. Disconnect the instrument from all voltage<br>sources while it is being opened.  |
| WARNING    | If this product is not used as specified, the protection provided by<br>the equipment could be impaired. This product must be used in a<br>normal condition (in which all means for protection are intact) only.  |
| WARNING    | The detachable power cord is the instrument disconnecting device.<br>It disconnects the mains circuits from the mains supply before other<br>parts of the instrument. The front panel switch is only a standby<br>switch and is not a LINE switch (disconnecting device).   |

# Cautions

| CAUTION | The CAUTION notice denotes a hazard. It calls attention to an operating procedure, practice, or the like, which if not correctly performed or adhered to, could result in damage to the product or loss of important data. Do not proceed beyond a CAUTION notice until the indicated conditions are fully understood and met.  |  |  |  |
|---------|---|--|--|--|
|         | Cautions applicable to this instrument are:   |  |  |  |
| CAUTION | Always use the three-prong ac power cord supplied with this instrument.<br>Failure to ensure adequate earth grounding (by not using this cord) can caus<br>instrument damage.   |  |  |  |
| CAUTION | This instrument has autoranging line voltage input; be sure the supply voltage is within the specified range.   |  |  |  |
| CAUTION | Ventilation Requirements: When installing the instrument in a cabinet, the convection into and out of the instrument must not be restricted. The ambient temperature (outside the cabinet) must be less than the maximum operating temperature of the instrument by 4 °C for every 100 watts dissipated in the cabinet. If the total power dissipated in the cabinet is greater than 800 watts, forced convection must be used. |  |  |  |
| CAUTION | This product is designed for use in Installation Category II and Pollution<br>Degree 2 per IEC 61010-1:2000, and 664 respectively.  |  |  |  |

# **Instrument Markings**

|                 | When you see this symbol on your instrument, you should refer to<br>the instrument's instruction manual for important information.  |
|-----------------|---|
| 4               | This symbol indicates hazardous voltages.   |
|                 | The laser radiation symbol is marked on products that have a laser output.  |
| $\sim$          | This symbol indicates that the instrument requires alternating current (ac) input.  |
| CE              | The CE mark is a registered trademark of the European<br>Community. If it is accompanied by a year, it indicates the year the<br>design was proven.   |
| <b>A</b>        | The CSA mark is a registered trademark of the Canadian Standards Association.   |
| <b>C</b> N10149 | This symbol indicates the product meets the Australian Standards.   |
| X               | This symbol indicates separate collection for electrical and<br>electronic equipment, mandated under EU law as of August 13,<br>2005. All electric and electronic equipment are required to be<br>separated from normal waste for disposal (Reference WEEE<br>Directive, 2002/96/EC).   |
| ISM1-A          | This text indicates that the instrument is an Industrial Scientific<br>and Medical Group 1 Class A product (CISPR 11, Clause 4).  |
| l               | This symbol indicates that the power line switch is ON.   |
| Ċ               | This symbol indicates that the power line switch is OFF or in STANDBY position.   |
| ÷               | Safety Earth Ground. This is a Safety Class I product (provided<br>with a protective earthing terminal). An uninterruptible<br>safety earth ground must be provided from the main power<br>source to the product input wiring terminals, power cord, or<br>supplied power cord set. Whenever it is likely that the<br>protection has been impaired, the product must be made<br>inoperative and secured against any unintended operation. |

# **Contacting Agilent**

By internet, phone, or fax, get assistance with all your test and measurement needs.

| This information supersede   | es all prior HP contact inform  | nation.  |  |  |  |  |
|--|---|--|--|--|--|--|
| Online assistance: ww  | ww.agilent.com/find/  | assist   |  |  |  |  |
| Americas   |   |  |  |  |  |  |
| <b>Brazil</b><br>( <i>tel</i> ) (+55) 11 3351 7012<br>( <i>fax</i> ) (+55) 11 3351 7024  | Canada<br>(tel) +1 877 894 4414<br>(fax) +1 303 662 3369  | Mexico<br>( <i>tel</i> ) 1 800 254 2440<br>( <i>fax</i> ) 1 800 254 4222   | United States<br>(tel) 800 829 4444<br>(alt) (+1) 303 662 3998<br>(fax) 800 829 4433   |  |  |  |
|  | Asia Pacifi   | c and Japan  |  |  |  |  |
| Australia<br>( <i>tel</i> ) 1 800 225 574<br>( <i>fax</i> ) 1 800 681 776<br>( <i>fax</i> ) 1 800 225 539                                  | China<br>( <i>tel</i> ) 800 810 0508<br>( <i>alt</i> ) 800 810 0510<br>( <i>fax</i> ) 800 810 0507<br>( <i>fax</i> ) 800 810 0362   | Hong Kong<br>( <i>tel</i> ) 800 933 229<br>( <i>fax</i> ) 800 900 701  | India<br>( <i>tel</i> ) 1600 112 626<br>( <i>fax</i> ) 1600 112 727<br>( <i>fax</i> ) 1600 113 040   |  |  |  |
| Japan (Bench)<br>( <i>tel</i> ) 0120 32 0119<br>( <i>alt</i> ) (+81) 426 56 7799<br>( <i>fax</i> ) 0120 01 2144                            | Japan (On-Site)<br>(tel) 0120 802 363<br>(alt) (+81) 426 56 7498<br>(fax) (+81) 426 60 8953   | Singapore<br>( <i>tel</i> ) 1 800 275 0880<br>( <i>fax</i> ) (+65) 6755 1235<br>( <i>fax</i> ) (+65) 6755 1214                               | South Korea<br>( <i>tel</i> ) 080 778 0011<br>( <i>fax</i> ) 080 778 0013  |  |  |  |
| <b>Taiwan</b><br>( <i>tel</i> ) 0800 047 669<br>( <i>fax</i> ) 0800 047 667<br>( <i>fax</i> ) 886 3492 0779                                | Thailand           (tel) 1 800 2758 5822           (alt) (+66) 2267 5913           (fax) 1 800 656 336                              | Malaysia<br>( <i>tel</i> ) 1800 880 399<br>( <i>fax</i> ) 1800 801 054<br>rope   |  |  |  |  |
| Austria<br>(tel) 0820 87 44 11*<br>(fax) 0820 87 44 22   | Belgium<br>( <i>tel</i> ) (+32) (0)2 404 9340<br>( <i>alt</i> ) (+32) (0)2 404 9000<br>( <i>fax</i> ) (+32) (0)2 404 9395           | Denmark<br>( <i>tel</i> ) (+45) 7013 1515<br>( <i>alt</i> ) (+45) 7013 7313<br>( <i>fax</i> ) (+45) 7013 1555                                | <b>Finland</b><br>( <i>tel</i> ) (+358) 10 855 2100<br>( <i>fax</i> ) (+358) (0) 10 855 2923   |  |  |  |
| France           (tel) 0825 010 700*           (alt) (+33) (0)1 6453 5623           (fax) 0825 010 701*                                    | Germany<br>( <i>tel</i> ) 01805 24 6333*<br>( <i>alt</i> ) 01805 24 6330*<br>( <i>fax</i> ) 01805 24 6336*                          | <b>Ireland</b><br>( <i>tel</i> ) (+353) (0)1 890 924 204<br>( <i>alt</i> ) (+353) (0)1 890 924 206<br>( <i>fax</i> ) (+353) (0)1 890 924 024 | <b>Israel</b><br>( <i>tel</i> ) (+972) 3 9288 500<br>( <i>fax</i> ) (+972) 3 9288 501  |  |  |  |
| <b>Italy</b><br>( <i>tel</i> ) (+39) (0)2 9260 8484<br>( <i>fax</i> ) (+39) (0)2 9544 1175   | Luxemburg<br>( <i>tel</i> ) (+32) (0)2 404 9340<br>( <i>alt</i> ) (+32) (0)2 404 9000<br>( <i>fax</i> ) (+32) (0)2 404 9395         | Netherlands<br>( <i>tel</i> ) (+31) (0)20 547 2111<br>( <i>alt</i> ) (+31) (0)20 547 2000<br>( <i>fax</i> ) (+31) (0)20 547 2190             | <b>Russia</b><br>( <i>tel</i> ) (+7) 095 797 3963<br>( <i>alt</i> ) (+7) 095 797 3900<br>( <i>fax</i> ) (+7) 095 797 3901                  |  |  |  |
| <b>Spain</b><br>( <i>tel</i> ) (+34) 91 631 3300<br>( <i>alt</i> ) (+34) 91 631 3000<br>( <i>fax</i> ) (+34) 91 631 3301                   | Sweden<br>(tel) 0200 88 22 55*<br>(alt) (+46) (0)8 5064 8686<br>(fax) 020 120 2266*   | Switzerland (French)<br>( <i>tel</i> ) 0800 80 5353 opt. 2*<br>( <i>alt</i> ) (+33) (0)1 6453 5623<br>( <i>fax</i> ) (+41) (0)22 567 5313    | Switzerland (German)<br>( <i>tel</i> ) 0800 80 5353 opt. 1*<br>( <i>alt</i> ) (+49) (0)7031 464 6333<br>( <i>fax</i> ) (+41) (0)1 272 7373 |  |  |  |
| Switzerland (Italian)<br>( <i>tel</i> ) 0800 80 5353 opt. 3*<br>( <i>alt</i> ) (+39) (0)2 9260 8484<br>( <i>fax</i> ) (+41) (0)22 567 5314 | United Kingdom<br>( <i>tel</i> ) (+44) (0)7004 666666<br>( <i>alt</i> ) (+44) (0)7004 123123<br>( <i>fax</i> ) (+44) (0)7004 444555 | number; ( <i>fax</i> ) = FAX number; * =   | = in country number 11/16/04   |  |  |  |